

# SLD50N06T

## 60V N-Channel MOSFET

### General Description

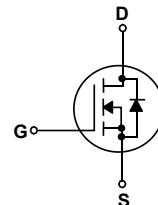
This Power MOSFET is produced using Msemitek's advanced TRENCH technology. This advanced technology has been especially tailored to minimize conduction loss, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

### Features

- 50A, 60V,  $R_{DS(on)Typ} = 12.4\text{m}\Omega @ V_{GS} = 10\text{ V}$
- $R_{DS(on)Typ} = 15.7\text{m}\Omega @ V_{GS} = 4.5\text{ V}$
- Low gate charge ( typical 27.2nC)
- High ruggedness
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability

### Application

- PWM Application
- Load Switch
- Power Management



### Absolute Maximum Ratings

$T_C = 25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	SLD50N06T	Units
$V_{DSS}$	Drain-Source Voltage	60	V
$I_D$	Drain Current - Continuous ( $T_C = 25^\circ\text{C}$ )	50	A
	- Continuous ( $T_C = 100^\circ\text{C}$ )	33	A
$I_{DM}$	Drain Current - Pulsed	(Note 1)	A
$V_{GSS}$	Gate-Source Voltage	$\pm 20$	V
$E_{AS}$	Single Pulsed Avalanche Energy	(Note 2)	mJ
$P_D$	Power Dissipation ( $T_C = 25^\circ\text{C}$ )	74	W
$R_{\theta JC}$	Thermal Resistance, Junction to Case	1.69	$^\circ\text{C}/\text{W}$
$T_J, T_{STG}$	Operating and Storage Temperature Range	-55 to +150	$^\circ\text{C}$
$T_L$	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	$^\circ\text{C}$

\* Drain current limited by maximum junction temperature.

## Package Marking

Part Number	Top Marking	Package	Packing Method	MOQ	QTY
SLD50N06T	SLD50N06T	D-Pak	Tape & Reel	2500	25000

## Electrical Characteristics

$T_c = 25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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### Off Characteristics

$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}} = 0 \text{ V}, I_{\text{D}} = 250 \mu\text{A}$	60	--	--	V
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{\text{DS}} = 60 \text{ V}, V_{\text{GS}} = 0 \text{ V}$	--	--	1	$\mu\text{A}$
		$V_{\text{DS}} = 48 \text{ V}, T_c = 150^\circ\text{C}$	--	--	10	$\mu\text{A}$
$I_{\text{GSSF}}$	Gate-Body Leakage Current, Forward	$V_{\text{GS}} = 20 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	--	--	100	nA
$I_{\text{GSSR}}$	Gate-Body Leakage Current, Reverse	$V_{\text{GS}} = -20 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	--	--	-100	nA

### On Characteristics

$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{DS}} = V_{\text{GS}}, I_{\text{D}} = 250 \mu\text{A}$	1.0	--	2.2	V
$R_{\text{DS(on)}}$	Static Drain-Source On-Resistance	$V_{\text{GS}} = 10 \text{ V}, I_{\text{D}} = 20 \text{ A}$	--	12.5	16	$\text{m}\Omega$
		$V_{\text{GS}} = 4.5 \text{ V}, I_{\text{D}} = 20 \text{ A}$	--	15.9	20	

### Dynamic Characteristics

$C_{\text{iss}}$	Input Capacitance	$V_{\text{DS}} = 25 \text{ V}, V_{\text{GS}} = 0 \text{ V}, f = 1.0 \text{ MHz}$	--	2780	--	pF
$C_{\text{oss}}$	Output Capacitance		--	112	--	pF
$C_{\text{rss}}$	Reverse Transfer Capacitance		--	102	--	pF

### Switching Characteristics

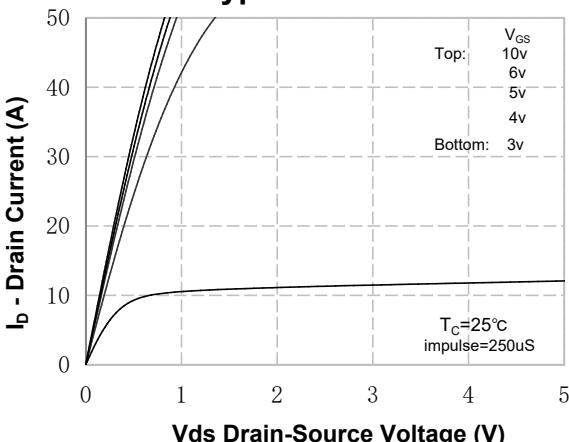
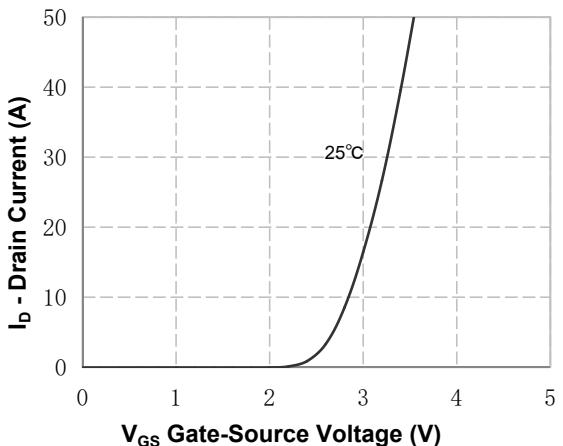
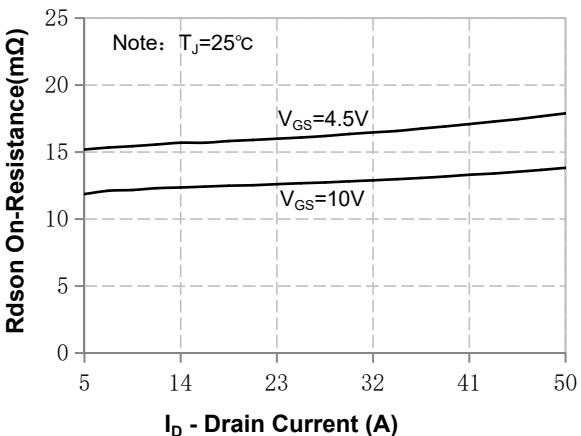
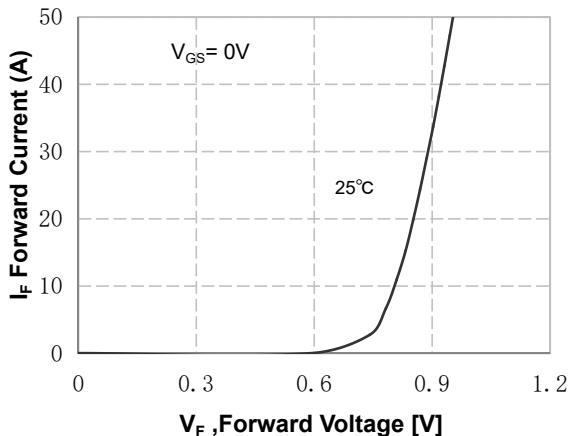
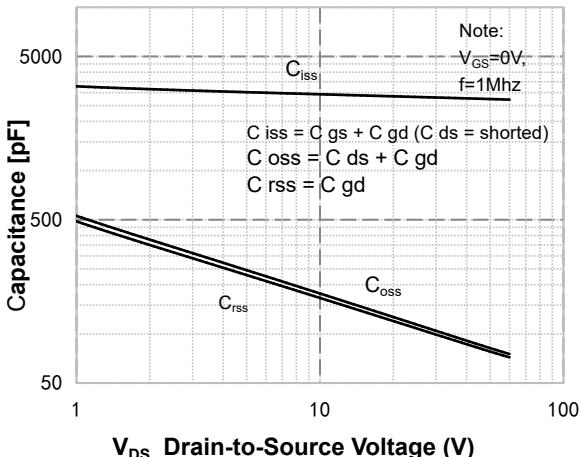
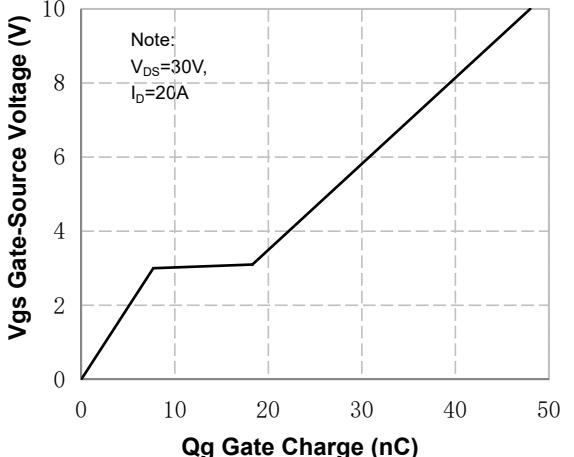
$t_{\text{d(on)}}$	Turn-On Delay Time	$V_{\text{DD}} = 30 \text{ V}, I_{\text{D}} = 30 \text{ A}, R_{\text{G}} = 1.8 \Omega, V_{\text{GS}} = 10 \text{ V}$ (Note 3)	--	15	--	ns
$t_r$	Turn-On Rise Time		--	105	--	ns
$t_{\text{d(off)}}$	Turn-Off Delay Time		--	60	--	ns
$t_f$	Turn-Off Fall Time		--	65	--	ns
$Q_g$	Total Gate Charge	$V_{\text{DS}} = 30 \text{ V}, I_{\text{D}} = 20 \text{ A}, V_{\text{GS}} = 10 \text{ V}$ (Note 3)	--	48	--	nC
$Q_{\text{gs}}$	Gate-Source Charge		--	7.7	--	nC
$Q_{\text{gd}}$	Gate-Drain Charge		--	11.2	--	nC
$R_{\text{G}}$	Gate Resistance	$f = 1 \text{ MHz}$	--	2.1	--	$\Omega$

### Drain-Source Diode Characteristics and Maximum Ratings

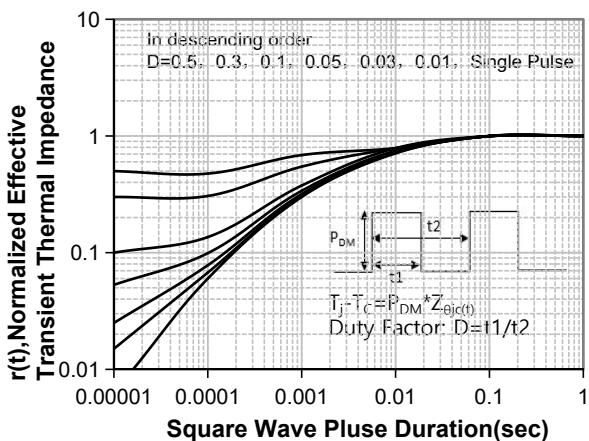
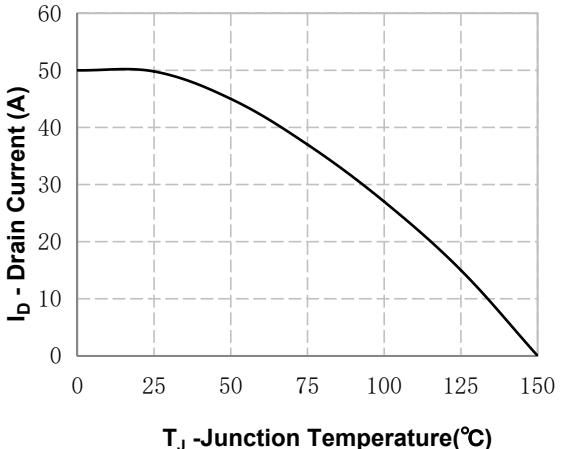
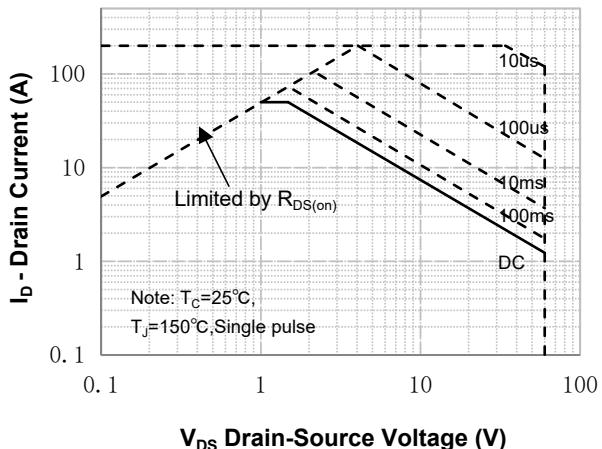
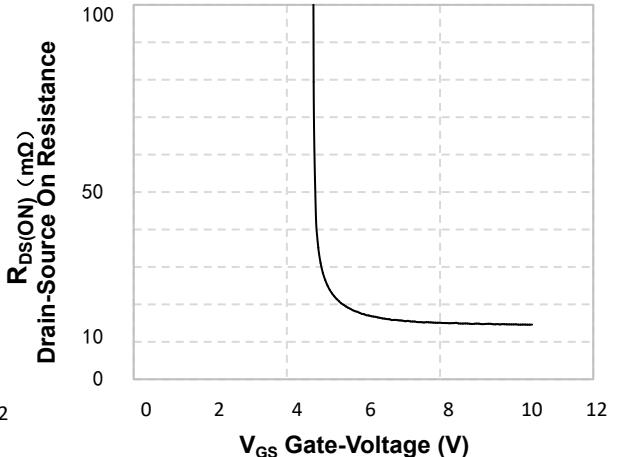
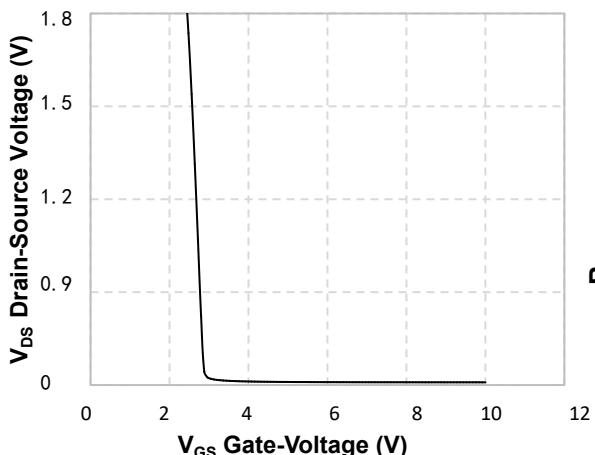
$I_s$	Maximum Continuous Drain-Source Diode Forward Current	--	--	50	A	
$I_{\text{SM}}$	Maximum Pulsed Drain-Source Diode Forward Current	--	--	200	A	
$V_{\text{SD}}$	Drain-Source Diode Forward Voltage	$V_{\text{GS}} = 0 \text{ V}, I_s = 15 \text{ A}$	--	--	1.4	V
$t_{\text{rr}}$	Reverse Recovery Time	$V_{\text{GS}} = 0 \text{ V}, I_s = 30 \text{ A}, dI_F / dt = 100 \text{ A/us}$	--	60	--	ns
$Q_{\text{rr}}$	Reverse Recovery Charge		--	80	--	nC

#### Notes:

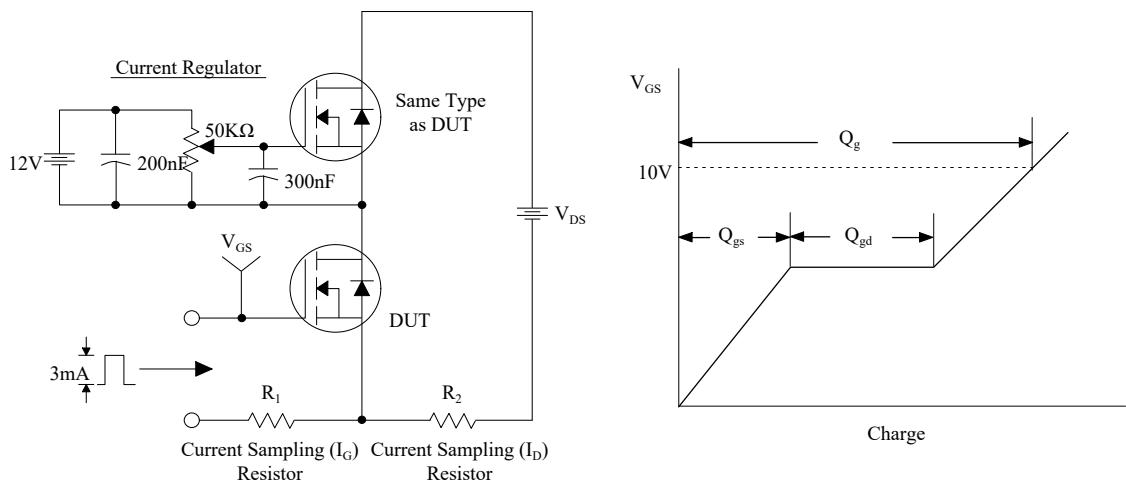
1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
2. EAS condition:  $T_j = 25^\circ\text{C}$ ,  $V_{\text{DD}} = 10 \text{ V}$ ,  $V_G = 10 \text{ V}$ ,  $R_{\text{G}} = 25 \Omega$ ,  $L = 0.5 \text{ mH}$
3. Pulse Test: Pulse Width  $\leq 300 \mu\text{s}$ , Duty Cycles  $\leq 0.5\%$

**N-Channel Typical Characteristics****Figure 1. On-Region Characteristics****Figure 2. Transfer Characteristics****Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage****Figure 4. Body Diode Forward Voltage Variation with Source Current****Figure 5. Capacitance Characteristics****Figure 6. Gate Charge Characteristics**

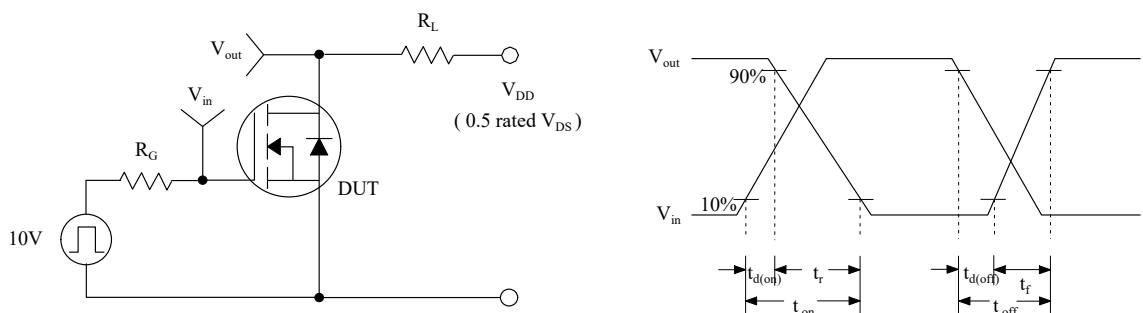
## N-Channel Typical Characteristics (Continued)



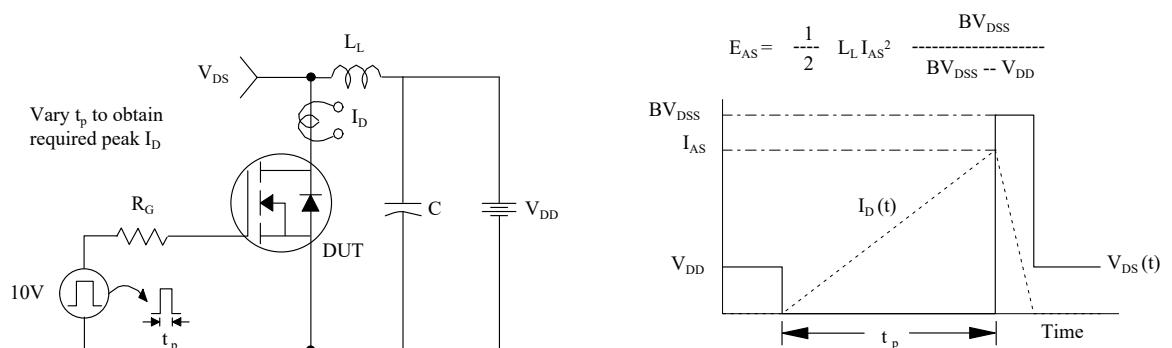
## Gate Charge Test Circuit & Waveform



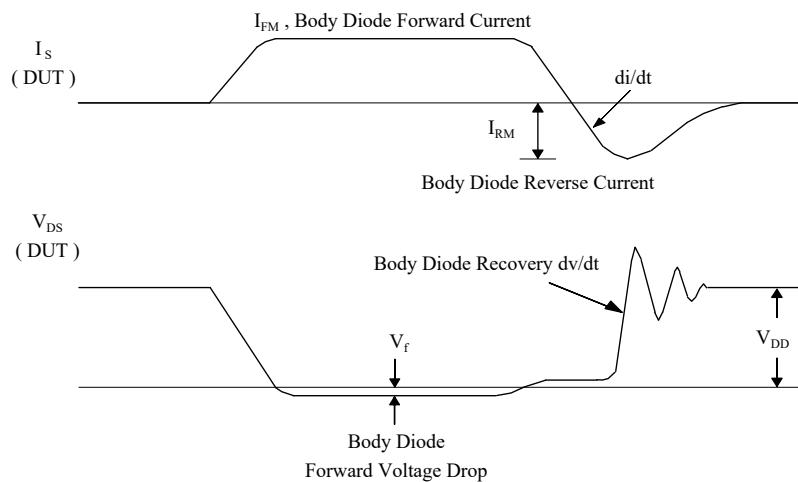
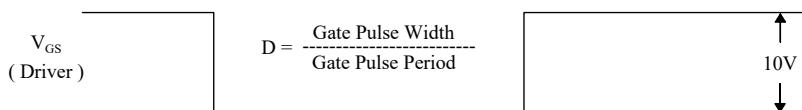
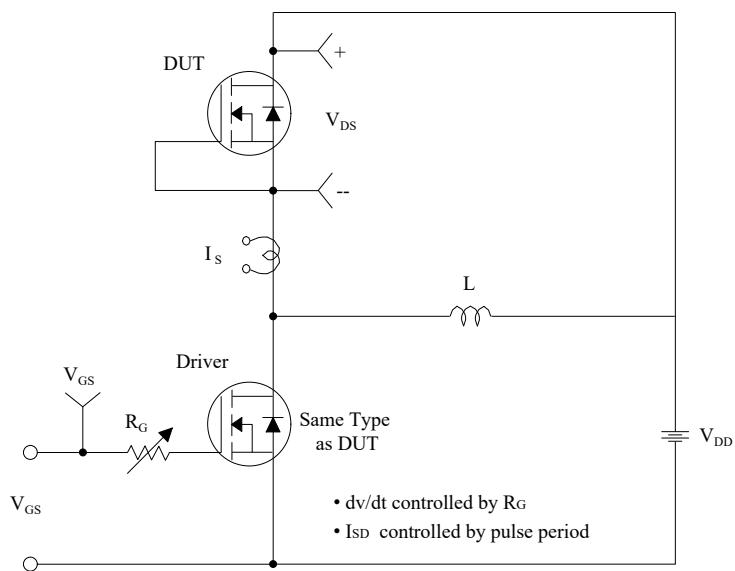
## Resistive Switching Test Circuit & Waveforms



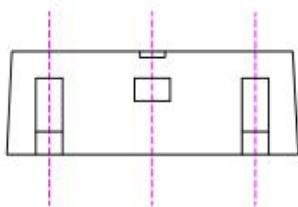
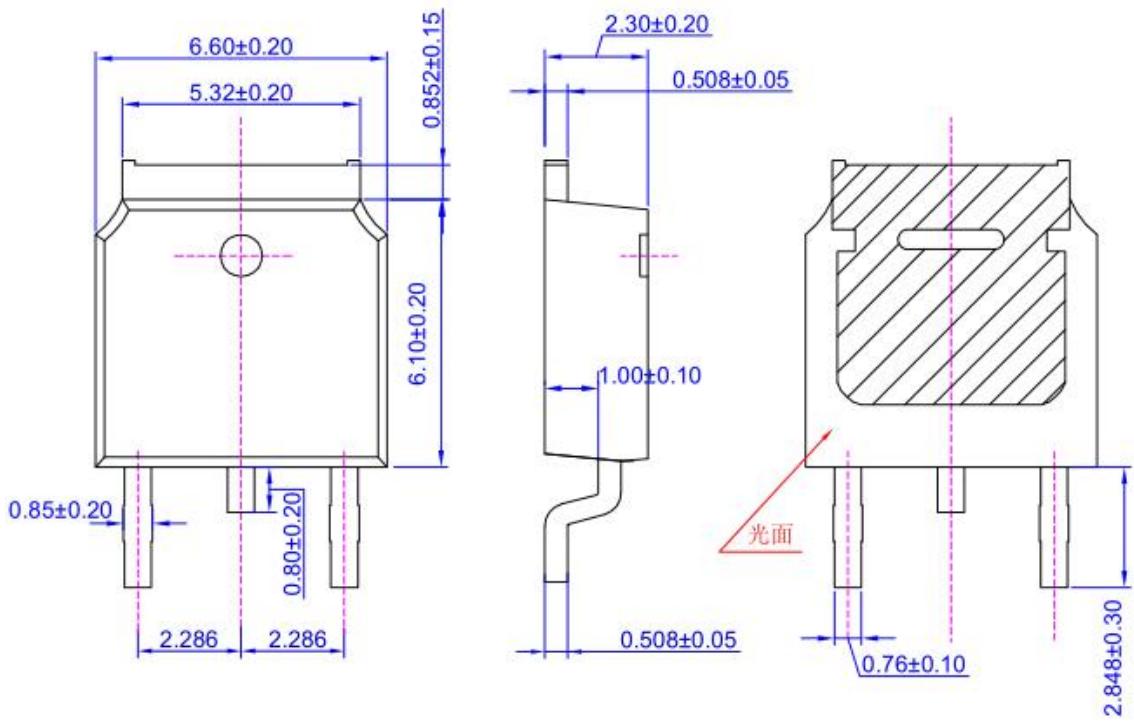
## Unclamped Inductive Switching Test Circuit & Waveforms



## Peak Diode Recovery dv/dt Test Circuit & Waveforms



## TO-252 OUTLINE



## NOTE:

- 1The plastic package is not marked as smooth surfaceRa=0.1;Subglossy surfaceRa=0.8
- 2.Undeclared tolerance $\pm 0.25$ ,Unmarked filletRmax=0.25

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